



General Description

The WST3401A is the highest performance trench P-Ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the small power switching and load switch applications .

The WST3401A meet the RoHS and Green Product requirement, with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

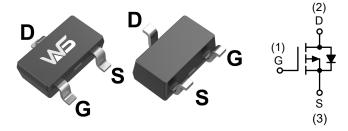
Product Summery

BV _{DSS}	R _{DSON}	I _D
-30V	48mΩ	-5.0A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23-3L Pin Configuration



Absolute Maximum Ratings

		Rating		
Symbol	Parameter	10s Steady State		Units
V _{DS}	Drain-Source Voltage	-;	30	V
V_{GS}	Gate-Source Voltage	<u>±</u>	12	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ -10V ¹	-5.7	-5.0	Α
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ -10V ¹	-4.5	-4.0	Α
I _{DM}	Pulsed Drain Current ²	-17		Α
P _D @T _A =25℃	Total Power Dissipation ³	1.32 1		W
P _D @T _A =70°C	Total Power Dissipation ³	0.84 0.64		W
T _{STG}	Storage Temperature Range	-55 to 150		$^{\circ}$
TJ	Operating Junction Temperature Range	-55 to 150		${\mathbb C}$

Thermal Data

Symbol	Parameter		Max.	Unit
$R_{ heta JA}$	Thermal Resistance Junction-Ambient ¹		125	°C/W
$R_{ heta JA}$	Thermal Resistance Junction-Ambient ¹ (t ≤10s)		95	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹		80	°C/W



Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I_D =-250uA	-30			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25 $^{\circ}{\!$		-0.023		V/℃	
D	Static Drain Source On Decistance ²			48	57		
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-2A		55	64	${4}$ m Ω	
V _{GS(th)}	Gate Threshold Voltage	\/ -\/ - 250A		-0.6	-1.2	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250uA$		4		mV/℃	
	Drain Source Lookage Current	V_{DS} =-24V , V_{GS} =0V , T_J =25 $^{\circ}$ C			-1	uA	
I _{DSS}	Drain-Source Leakage Current	V_{DS} =-24V , V_{GS} =0V , T_J =55 $^{\circ}$ C			-5	uA	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = \pm 12 V , V_{DS} =0 V			±100	nA	
gfs	Forward Transconductance	V_{DS} =-5V , I_{D} =-3A		11		S	
Q_g	Total Gate Charge (-4.5V)			6.2	9.0		
Q_{gs}	Gate-Source Charge	V_{DS} =-15V , V_{GS} =-4.5V , I_{D} =-3A		2.2	3.2	nC	
Q_gd	Gate-Drain Charge			1.8	2.7		
T _{d(on)}	Turn-On Delay Time			2.7	5.6		
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_{G} =3.3 Ω ,		8.3	15.1	no	
$T_{d(off)}$	Turn-Off Delay Time	I _D =-3A		6	12.0	ns	
T _f	Fall Time			38	78.0		
C _{iss}	Input Capacitance			580	816		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		98	140	pF	
C _{rss}	Reverse Transfer Capacitance			77	112		

Diode Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	N/ -0\/ Fares Current			-4.0	Α
I _{SM}	Pulsed Source Current ^{2,4}	V _D =0V , Force Current			-14	Α
V _{SD}	Diode Forward Voltage ² V _{GS} =	=0V , I _S =-1A , T _J =25℃			-1	V
t _{rr}	Reverse Recovery Time			7.6		nS
Q_{rr}	Reverse Recovery Charge	3A , dl/dt=100A/µs , Tյ=25℃		2.4		nC

Note

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10 sec., t<10 sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

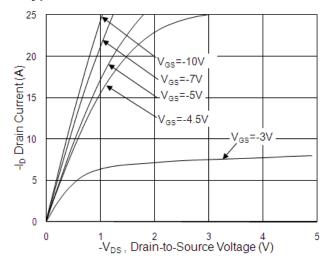


Fig.1 Typical Output Characteristics

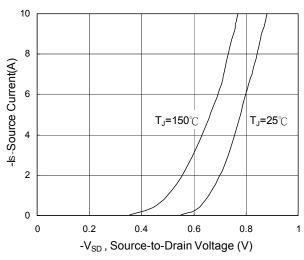


Fig.3 Forward Characteristics of Reverse

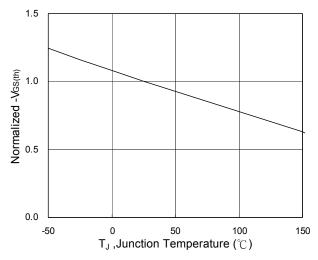


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

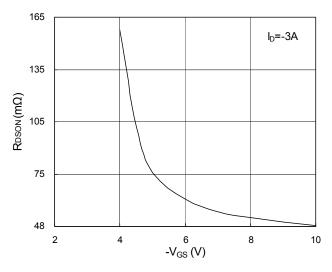


Fig.2 On-Resistance v.s Gate-Source

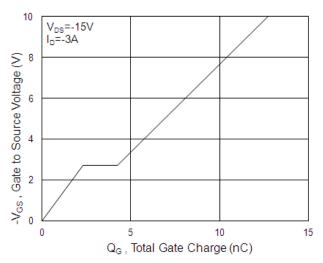


Fig.4 Gate-Charge Characteristics

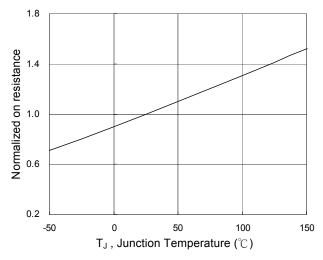
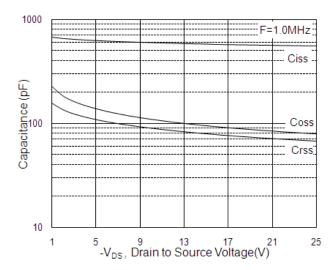


Fig.6 Normalized R_{DSON} vs T_J





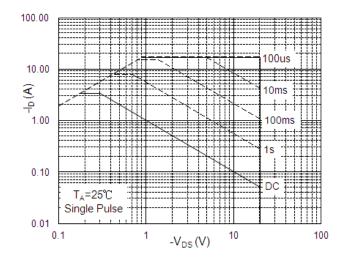


Fig.7 Capacitance

Fig.8 Safe Operating Area

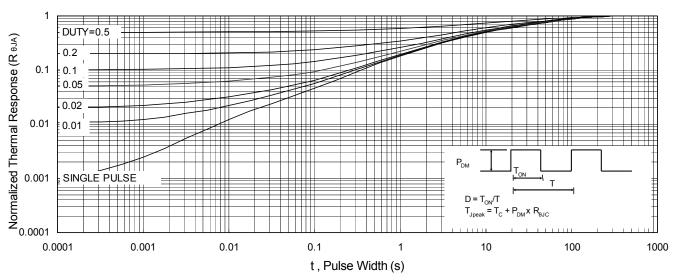
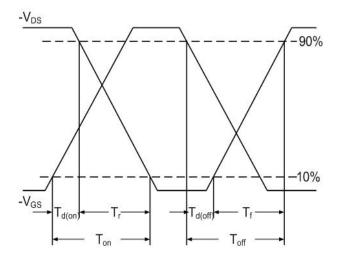


Fig.9 Normalized Maximum Transient Thermal Impedance



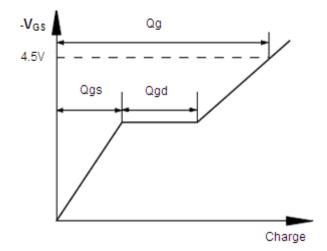
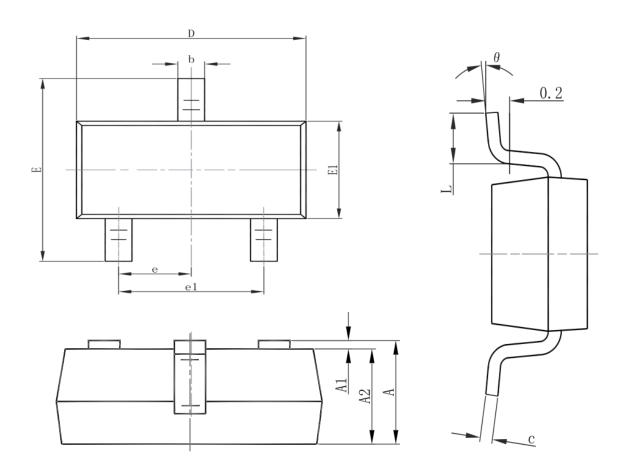


Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform



Packaging information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E1	1.500	1.700	0.059	0.067	
E	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	



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